

AM1D probe identification and configuration data

Item	AM1DV2 Audio Magnetic 1D Field Probe	
Type No	SP AM1 001 AF	<u> </u>
Serial No	1064	

Overall length	296 mm
Tip diameter	6.0 mm (at the tip)
Sensor offset	3.0 mm (centre of sensor from tip)
Internal Amplifier	40 dB

Manufacturer / Origin	Schmid & Partner Engineering AG, Zurich, Switzerland
Manufacturing date	November 06, 2007
Last calibration date	July 22, 2016

Calibration data

Sensitivity at 1 kHz	(in DASY system)	0.0657 V / (A/m)	+/- 2.2 % (k=2)
Sensor angle	(in DASY system)	0.44°	+/- 0.5 ° (k=2)
Connector rotation angle	(in DASY system)	104.1 °	+/- 3.6 ° (k=2)

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.



ANNEX E DAE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service**

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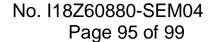
Client

Accreditation No.: SCS 0108

CTTL (Auden) Certificate No: DAE4-777_Sep17 **CALIBRATION CERTIFICATE** Object DAE4 - SD 000 D04 BM - SN: 777 QA CAL-06.v29 Calibration procedure(s) Calibration procedure for the data acquisition electronics (DAE) Calibration date: September 08, 2017 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Certificate No.) Scheduled Calibration Keithley Multimeter Type 2001 SN: 0810278 31-Aug-17 (No:21092) Aug-18 Secondary Standards ID# Check Date (in house) Scheduled Check Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-17 (in house check) In house check: Jan-18 Calibrator Box V2.1 SE UMS 006 AA 1002 05-Jan-17 (in house check) In house check: Jan-18 Name Function Signature Calibrated by: Dominique Steffen Laboratory Technician Approved by: Sven Kühn Deputy Manager Issued: September 8, 2017

Certificate No: DAE4-777_Sep17

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Glossary

DAE Connector angle

data acquisition electronics

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

• *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.

- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement
A/D - Converter Resolution nominal
High Range: 1LSB = 6.1μV , full range = -100...+300 mV full range = -1......+3mV Low Range: 1LSB = 61nV, DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	х	Υ	z
High Range	405.400 ± 0.02% (k=2)	405.869 ± 0.02% (k=2)	405.579 ± 0.02% (k=2)
Low Range	3.96640 ± 1.50% (k=2)	3.96264 ± 1.50% (k=2)	4.00499 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	97.0°±1°
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μ\	V) Difference (μV)	Error (%)
Channel X + Ing	out 200022.73	-12.42	-0.01
Channel X + Inp	ut 20003.49	-1.25	-0.01
Channel X - Inp	ut -19998.82	6.77	-0.03
Channel Y + Inp	ut 200025.10	-10.04	-0.01
Channel Y + Inp	ut 20007.22	2.54	0.01
Channel Y - Inp	ıt -20002.34	3.30	-0.02
Channel Z + Inp	ut 200028.10	-6.82	-0.00
Channel Z + Inp	ut 20002.36	-2.19	-0.01
Channel Z - Inpo	ıt -20003.64	2.12	-0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.54	-0.37	-0.02
Channel X + Input	201.37	0.50	0.25
Channel X - Input	-199.19	-0.20	0.10
Channel Y + Input	1999.95	-0.89	-0.04
Channel Y + Input	200.04	-0.75	-0.37
Channel Y - Input	-199.96	-0.85	0.43
Channel Z + Input	2001.05	0.20	0.01
Channel Z + Input	199.88	-0.86	-0.43
Channel Z - Input	-200.02	-0.88	0.44

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.45	3.79
	- 200	3.93	0.83
Channel Y	200	7.70	7.39
	- 200	-9.52	-8.90
Channel Z	200	7.51	6.49
	- 200	-9.21	-8.71

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-1.61	-2.84
Channel Y	200	8.30	-	0.46
Channel Z	200	6.69	5.02	=1

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15919	14652
Channel Y	16343	14477
Channel Z	16033	14911

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

<u> </u>	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.50	-2.04	0.95	0.51
Channel Y	1.56	0.40	2.80	0.48
Channel Z	0.26	-0.78	1.16	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm) 200	
Channel X	200		
Channel Y	200	200	
Channel Z	200	200	

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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The photos of HAC test are presented in the additional document:

Appendix to test report no. I18Z60880-SEM03/04

The photos of HAC test